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Details

E·XFI

Product Status	Active
Core Processor	S08
Core Size	8-Bit
Speed	40MHz
Connectivity	CANbus, I ² C, LINbus, SCI, SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	25
Program Memory Size	60KB (60K x 8)
Program Memory Type	FLASH
EEPROM Size	·
RAM Size	3K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 10x12b
Oscillator Type	External
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	32-LQFP
Supplier Device Package	32-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mc9s08dv60mlc

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



MC9S08DV60 Data Sheet

Covers MC9S08DV60 MC9S08DV48 MC9S08DV32 MC9S08DV16

MC9S08DV60 Rev 3 6/2008

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Revision History

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The following revision history table summarizes changes contained in this document.

Revision Number	Revision Date	Description of Changes			
1	6/2006	Advance Information version for alpha samples customers			
2	9/2007	Product Launch. Removed the 64-pin QFN package. Changed from standard to extended mode for MSCAN registers in register summary. Corrected Block diagrams for SCI. Updated the latest Temp Sensor information. Made FTSTMOD reserved. Updated device to use the ADC 12-bit module. Revised the MCG module. Updated the TPM block module to version 3. Added the TPM block module version 2 as an appendix for devices using 3M05C (or earlier) mask sets. Heavily revised the Electricals appendix.			
3	6/2008	Sustaining Update. Incorporated PS Issues # 2765, 3177, 3236, 3292, 3301, 3311, 3312, 3326, 3335, 3345, 3382, 2795, 3382 and 3386 PLL Jitter Spec update. Also, added internal reference clock trim adjustment statement to Features page. Updated the TPM module to the latest version. Adjusted values in Table A-13 Control Timing row 2 and in Table A-6 DC Characteristics row 24 so that it references 5.0 V instead of 3.0 V.			

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NOTE

To avoid extra current drain from floating input pins, the reset initialization routine in the application program should either enable on-chip pull-up devices or change the direction of unused or non-bonded pins to outputs so they do not float.



4.5.7 Block Protection

The block protection feature prevents the protected region of Flash from program or erase changes. Block protection is controlled through the Flash protection register (FPROT). The FPS bits determine the protected region of Flash. See Section 4.5.10.4, "Flash Protection Register (FPROT and NVPROT)."

After exit from reset, FPROT is loaded with the contents of the NVPROT location, which is in the nonvolatile register block of the Flash memory. Any FPROT write that attempts to decrease the size of the protected region will be ignored. Because NVPROT is within the last sector of Flash, if any amount of memory is protected, NVPROT is itself protected and cannot be unprotected (intentionally or unintentionally) by the application software. FPROT can be written through background debug commands, which provides a way to erase and reprogram protected Flash memory.

One use for block protection is to block protect an area of Flash memory for a bootloader program. this bootloader program can call a routine outside of Flash that can be used to sector erase the rest of the Flash memory and reprogram it. The bootloader is protected even if MCU power is lost during an erase and reprogram operation.

4.5.8 Vector Redirection

While any Flash is block protected, the reset and interrupt vectors will be protected. Vector redirection allows users to modify interrupt vector information without unprotecting bootloader and reset vector space. Vector redirection is enabled by programming the FNORED bit in the NVOPT register located at address 0xFFBF to 0. For redirection to occur, at least some portion of the Flash memory must be block protected by programming the NVPROT register located at address 0xFFBD. All interrupt vectors (memory locations 0xFFC0–0xFFFD) are redirected, though the reset vector (0xFFFE:0xFFFF) is not.

For example, if 1536 bytes of Flash are protected, the protected address region is from 0xFA00 through 0xFFFF. The interrupt vectors (0xFFC0–0xFFFD) are redirected to the locations 0xF9C0–0xF9FD. If vector redirection is enabled and an interrupt occurs, the values in the locations 0xF9E0:0xF9E1 are used for the vector instead of the values in the locations 0xFFE0:0xFFE1. This allows the user to reprogram the unprotected portion of the Flash with new program code including new interrupt vector values while leaving the protected area, which includes the default vector locations, unchanged.

4.5.9 Security

The MC9S08DV60 Series includes circuitry to prevent unauthorized access to the contents of Flash and RAM memory. When security is engaged, Flash and RAM are considered secure resources. Direct-page registers, high-page registers, and the background debug controller are considered unsecured resources. Programs executing within secure memory have normal access to any MCU memory locations and resources. Attempts to access a secure memory location with a program executing from an unsecured memory space or through the background debug interface are blocked (writes are ignored and reads return all 0s).

Security is engaged or disengaged based on the state of two register bits (SEC[1:0]) in the FOPT register. During reset, the contents of the nonvolatile location NVOPT are copied from Flash into the working FOPT register in high-page register space. A user engages security by programming the NVOPT location, which can be performed at the same time the Flash memory is programmed. The 1:0 state disengages

6.5.2.3 Port B Pull Enable Register (PTBPE)



Figure 6-13. Internal Pull Enable for Port B Register (PTBPE)

Table 6-11. PTBPE Register Field Descriptions

Field	Description
7:0	Internal Pull Enable for Port B Bits — Each of these control bits determines if the internal pull-up or pull-down
PTBPE[7:0]	device is enabled for the associated PTB pin. For port B pins that are configured as outputs, these bits have no
	effect and the internal pull devices are disabled.
	0 Internal pull-up/pull-down device disabled for port B bit n.
	1 Internal pull-up/pull-down device enabled for port B bit n.

NOTE

Pull-down devices only apply when using pin interrupt functions, when corresponding edge select and pin select functions are configured.

6.5.2.4 Port B Slew Rate Enable Register (PTBSE)



Figure 6-14. Slew Rate Enable for Port B Register (PTBSE)

Table 6-12. PTBSE Register Field Descriptions

Field	Description
7:0 PTBSE[7:0]	 Output Slew Rate Enable for Port B Bits — Each of these control bits determines if the output slew rate control is enabled for the associated PTB pin. For port B pins that are configured as inputs, these bits have no effect. Output slew rate control disabled for port B bit n. Output slew rate control enabled for port B bit n.

Note: Slew rate reset default values may differ between engineering samples and final production parts. Always initialize slew rate control to the desired value to ensure correct operation.



Chapter 6 Parallel Input/Output Control

6.5.3 Port C Registers

Port C is controlled by the registers listed below.

6.5.3.1 Port C Data Register (PTCD)



Figure 6-19. Port C Data Register (PTCD)

Table 6-17. PTCD Register Field Descriptions

Field	Description
7:0 PTCD[7:0]	Port C Data Register Bits — For port C pins that are inputs, reads return the logic level on the pin. For port C pins that are configured as outputs, reads return the last value written to this register. Writes are latched into all bits of this register. For port C pins that are configured as outputs, the logic level is driven out the corresponding MCU pin. Reset forces PTCD to all 0s, but these 0s are not driven out the corresponding pins because reset also configures all port pins as high-impedance inputs with pull-ups disabled.

6.5.3.2 Port C Data Direction Register (PTCDD)

	7	6	5	4	3	2	1	0
R W	PTCDD7	PTCDD6	PTCDD5	PTCDD4	PTCDD3	PTCDD2	PTCDD1	PTCDD0
Reset:	0	0	0	0	0	0	0	0

Figure 6-20. Port C Data Direction Register (PTCDD)

Table 6-18. PTCDD Register Field Descriptions

Field	Description
7:0 PTCDD[7:0]	Data Direction for Port C Bits — These read/write bits control the direction of port C pins and what is read for PTCD reads.
	 Input (output driver disabled) and reads return the pin value. Output driver enabled for port C bit n and PTCD reads return the contents of PTCDn.



8.5.2.3 Example #3: Moving from BLPI to FEE Mode: External Crystal = 4 MHz, Bus Frequency = 16 MHz

In this example, the MCG will move through the proper operational modes from BLPI mode at a 16 kHz bus frequency running off of the internal reference clock (see previous example) to FEE mode using a 4 MHz crystal configured for a 16 MHz bus frequency. First, the code sequence will be described. Then a flowchart will be included which illustrates the sequence.

- 1. First, BLPI must transition to FBI mode.
 - a) MCGC2 = 0x00 (%00000000)
 - LP (bit 3) in MCGSC is 0
 - b) Optionally, loop until LOCK (bit 6) in the MCGSC is set, indicating that the FLL has acquired lock. Although the FLL is bypassed in FBI mode, it is still enabled and running.
- 2. Next, FBI will transition to FEE mode.
 - a) MCGC2 = 0x36 (%00110110)
 - RANGE (bit 5) set to 1 because the frequency of 4 MHz is within the high frequency range
 - HGO (bit 4) set to 1 to configure external oscillator for high gain operation
 - EREFS (bit 2) set to 1, because a crystal is being used
 - ERCLKEN (bit 1) set to 1 to ensure the external reference clock is active
 - b) Loop until OSCINIT (bit 1) in MCGSC is 1, indicating the crystal selected by the EREFS bit has been initialized.
 - c) MCGC1 = 0x38 (%00111000)
 - CLKS (bits 7 and 6) set to %00 in order to select the output of the FLL as system clock source
 - RDIV (bits 5-3) set to %111, or divide-by-128 because 4 MHz / 128 = 31.25 kHz which is in the 31.25 kHz to 39.0625 kHz range required by the FLL
 - IREFS (bit 1) cleared to 0, selecting the external reference clock
 - d) Loop until IREFST (bit 4) in MCGSC is 0, indicating the external reference clock is the current source for the reference clock
 - e) Optionally, loop until LOCK (bit 6) in the MCGSC is set, indicating that the FLL has reacquired lock.
 - f) Loop until CLKST (bits 3 and 2) in MCGSC are %00, indicating that the output of the FLL is selected to feed MCGOUT



9.1.2 Features

The ACMP has the following features:

- Full rail to rail supply operation.
- Selectable interrupt on rising edge, falling edge, or either rising or falling edges of comparator output.
- Option to compare to fixed internal bandgap reference voltage.
- Option to allow comparator output to be visible on a pin, ACMPxO.

9.1.3 Modes of Operation

This section defines the ACMP operation in wait, stop, and background debug modes.

9.1.3.1 ACMP in Wait Mode

The ACMP continues to run in wait mode if enabled before executing the appropriate instruction. Therefore, the ACMP can be used to bring the MCU out of wait mode if the ACMP interrupt is enabled (ACIE is set). For lowest possible current consumption, the ACMP should be disabled by software if not required as an interrupt source during wait mode.

9.1.3.2 ACMP in Stop Modes

The ACMP is disabled in all stop modes, regardless of the settings before executing the stop instruction. Therefore, the ACMP cannot be used as a wake up source from stop modes.

During stop2 mode, the ACMP module is fully powered down. Upon wake-up from stop2 mode, the ACMP module is in the reset state.

During stop3 mode, clocks to the ACMP module are halted. No registers are affected. In addition, the ACMP comparator circuit enters a low-power state. No compare operation occurs while in stop3.

If stop3 is exited with a reset, the ACMP is put into its reset state. If stop3 is exited with an interrupt, the ACMP continues from the state it was in when stop3 was entered.

9.1.3.3 ACMP in Active Background Mode

When the microcontroller is in active background mode, the ACMP continues to operate normally.

Field	Description					
7–6 MULT	IIC Multiplier Factor . The MULT bits define the multiplier factor, mul. This factor, along with the SC generates the IIC baud rate. The multiplier factor mul as defined by the MULT bits is provided below 00 mul = 01 01 mul = 02 10 mul = 04 11 Reserved	L divider, v.				
5–0 ICR	 IIC Clock Rate. The ICR bits are used to prescale the bus clock for bit rate selection. These bits and the N bits determine the IIC baud rate, the SDA hold time, the SCL Start hold time, and the SCL Stop hold time. Table 11-4 provides the SCL divider and hold values for corresponding values of the ICR. 					
	The SCL divider multiplied by multiplier factor mul generates IIC baud rate.					
	IIC baud rate = $\frac{\text{bus speed (Hz)}}{\text{mul} \times \text{SCLdivider}}$					
	SDA hold time is the delay from the falling edge of SCL (IIC clock) to the changing of SDA (IIC data	ı).				
	SDA hold time = bus period (s) \times mul \times SDA hold value	Eqn. 11-2				
	SCL start hold time is the delay from the falling edge of SDA (IIC data) while SCL is high (Start cond falling edge of SCL (IIC clock).	lition) to the				
	SCL Start hold time = bus period (s) \times mul \times SCL Start hold value	Eqn. 11-3				
	SCL stop hold time is the delay from the rising edge of SCL (IIC clock) to the rising edge of SDA SDA (IIC data) while SCL is high (Stop condition).					
	SCL Stop hold time = bus period (s) \times mul \times SCL Stop hold value	Eqn. 11-4				

Table 11-2. IICF Field Descriptions

For example, if the bus speed is 8 MHz, the table below shows the possible hold time values with different ICR and MULT selections to achieve an IIC baud rate of 100kbps.

MULT	ICR	Hold Times (µs)			
		SDA	SCL Start	SCL Stop	
0x2	0x00	3.500	3.000	5.500	
0x1	0x07	2.500	4.000	5.250	
0x1	0x0B	2.250	4.000	5.250	
0x0	0x14	2.125	4.250	5.125	
0x0	0x18	1.125	4.750	5.125	

Table 11-3. Hold Time Values for 8 MHz Bus Speed



12.3.14 MSCAN Transmit Error Counter (CANTXERR)

This register reflects the status of the MSCAN transmit error counter.





Read: Only when in sleep mode (SLPRQ = 1 and SLPAK = 1) or initialization mode (INITRQ = 1 and INITAK = 1)

Write: Unimplemented

NOTE

Reading this register when in any other mode other than sleep or initialization mode, may return an incorrect value. For MCUs with dual CPUs, this may result in a CPU fault condition.

Writing to this register when in special modes can alter the MSCAN functionality.

12.3.15 MSCAN Identifier Acceptance Registers (CANIDAR0-7)

On reception, each message is written into the background receive buffer. The CPU is only signalled to read the message if it passes the criteria in the identifier acceptance and identifier mask registers (accepted); otherwise, the message is overwritten by the next message (dropped).

The acceptance registers of the MSCAN are applied on the IDR0–IDR3 registers (see Section 12.4.1, "Identifier Registers (IDR0–IDR3)") of incoming messages in a bit by bit manner (see Section 12.5.3, "Identifier Acceptance Filter").

For extended identifiers, all four acceptance and mask registers are applied. For standard identifiers, only the first two (CANIDAR0/1, CANIDMR0/1) are applied.

	7	6	5	4	3	2	1	0
R W	AC7	AC6	AC5	AC4	AC3	AC2	AC1	AC0
Reset	0	0	0	0	0	0	0	0

Figure 12-19. MSCAN Identifier Acceptance Registers (First Bank) — CANIDAR0–CANIDAR3

Read: Anytime

Write: Anytime in initialization mode (INITRQ = 1 and INITAK = 1)



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Chapter 12 Freescale's Controller Area Network (S08MSCANV1)
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12.5.4.3 Emulation Modes

In all emulation modes, the MSCAN module behaves just like normal system operation modes as described within this specification.

12.5.4.4 Listen-Only Mode

In an optional CAN bus monitoring mode (listen-only), the CAN node is able to receive valid data frames and valid remote frames, but it sends only "recessive" bits on the CAN bus. In addition, it cannot start a transmision. If the MAC sub-layer is required to send a "dominant" bit (ACK bit, overload flag, or active error flag), the bit is rerouted internally so that the MAC sub-layer monitors this "dominant" bit, although the CAN bus may remain in recessive state externally.

12.5.4.5 Security Modes

The MSCAN module has no security features.

12.5.4.6 Loopback Self Test Mode

Loopback self test mode is sometimes used to check software, independent of connections in the external system, to help isolate system problems. In this mode, the transmitter output is internally connected to the receiver input. The RXCAN input pin is ignored and the TXCAN output goes to the recessive state (logic 1). The MSCAN behaves as it does normally when transmitting and treats its own transmitted message as a message received from a remote node. In this state, the MSCAN ignores the bit sent during the ACK slot in the CAN frame acknowledge field to ensure proper reception of its own message. Both transmit and receive interrupts are generated.

12.5.5 Low-Power Options

If the MSCAN is disabled (CANE = 0), the MSCAN clocks are stopped for power saving.

If the MSCAN is enabled (CANE = 1), the MSCAN has two additional modes with reduced power consumption, compared to normal mode: sleep and power down mode. In sleep mode, power consumption is reduced by stopping all clocks except those to access the registers from the CPU side. In power down mode, all clocks are stopped and no power is consumed.

Table 12-36 summarizes the combinations of MSCAN and CPU modes. A particular combination of modes is entered by the given settings on the CSWAI and SLPRQ/SLPAK bits.

For all modes, an MSCAN wake-up interrupt can occur only if the MSCAN is in sleep mode (SLPRQ = 1 and SLPAK = 1), wake-up functionality is enabled (WUPE = 1), and the wake-up interrupt is enabled (WUPIE = 1).



12.5.5.4 MSCAN Sleep Mode

The CPU can request the MSCAN to enter this low power mode by asserting the SLPRQ bit in the CANCTL0 register. The time when the MSCAN enters sleep mode depends on a fixed synchronization delay and its current activity:

- If there are one or more message buffers scheduled for transmission (TXEx = 0), the MSCAN will continue to transmit until all transmit message buffers are empty (TXEx = 1, transmitted successfully or aborted) and then goes into sleep mode.
- If the MSCAN is receiving, it continues to receive and goes into sleep mode as soon as the CAN bus next becomes idle.
- If the MSCAN is neither transmitting nor receiving, it immediately goes into sleep mode.



Figure 12-44. Sleep Request / Acknowledge Cycle

NOTE

The application software must avoid setting up a transmission (by clearing one or more TXEx flag(s)) and immediately request sleep mode (by setting SLPRQ). Whether the MSCAN starts transmitting or goes into sleep mode directly depends on the exact sequence of operations.

If sleep mode is active, the SLPRQ and SLPAK bits are set (Figure 12-44). The application software must use SLPAK as a handshake indication for the request (SLPRQ) to go into sleep mode.

When in sleep mode (SLPRQ = 1 and SLPAK = 1), the MSCAN stops its internal clocks. However, clocks that allow register accesses from the CPU side continue to run.

If the MSCAN is in bus-off state, it stops counting the 128 occurrences of 11 consecutive recessive bits due to the stopped clocks. The TXCAN pin remains in a recessive state. If RXF = 1, the message can be read and RXF can be cleared. Shifting a new message into the foreground buffer of the receiver FIFO (RxFG) does not take place while in sleep mode.

It is possible to access the transmit buffers and to clear the associated TXE flags. No message abort takes place while in sleep mode.



12.5.7.1 Description of Interrupt Operation

The MSCAN supports four interrupt vectors (see Table 12-37), any of which can be individually masked (for details see sections from Section 12.3.5, "MSCAN Receiver Interrupt Enable Register (CANRIER)," to Section 12.3.7, "MSCAN Transmitter Interrupt Enable Register (CANTIER)").

NOTE

The dedicated interrupt vector addresses are defined in the Resets and Interrupts chapter.

Interrupt Source	CCR Mask	Local Enable
Wake-Up Interrupt (WUPIF)	l bit	CANRIER (WUPIE)
Error Interrupts Interrupt (CSCIF, OVRIF)	l bit	CANRIER (CSCIE, OVRIE)
Receive Interrupt (RXF)	l bit	CANRIER (RXFIE)
Transmit Interrupts (TXE[2:0])	l bit	CANTIER (TXEIE[2:0])

Table 12-37. Interrupt Vectors

12.5.7.2 Transmit Interrupt

At least one of the three transmit buffers is empty (not scheduled) and can be loaded to schedule a message for transmission. The TXEx flag of the empty message buffer is set.

12.5.7.3 Receive Interrupt

A message is successfully received and shifted into the foreground buffer (RxFG) of the receiver FIFO. This interrupt is generated immediately after receiving the EOF symbol. The RXF flag is set. If there are multiple messages in the receiver FIFO, the RXF flag is set as soon as the next message is shifted to the foreground buffer.

12.5.7.4 Wake-Up Interrupt

A wake-up interrupt is generated if activity on the CAN bus occurs during MSCAN internal sleep mode. WUPE (see Section 12.3.1, "MSCAN Control Register 0 (CANCTL0)") must be enabled.

12.5.7.5 Error Interrupt

An error interrupt is generated if an overrun of the receiver FIFO, error, warning, or bus-off condition occurrs. Section 12.3.4.1, "MSCAN Receiver Flag Register (CANRFLG) indicates one of the following conditions:

- **Overrun** An overrun condition of the receiver FIFO as described in Section 12.5.2.3, "Receive Structures," occurred.
- CAN Status Change The actual value of the transmit and receive error counters control the CAN bus state of the MSCAN. As soon as the error counters skip into a critical range (Tx/Rx-warning, Tx/Rx-error, bus-off) the MSCAN flags an error condition. The status change, which caused the error condition, is indicated by the TSTAT and RSTAT flags (see



Chapter 14 Serial Communications Interface (S08SCIV4)

14.2 Register Definition

The SCI has eight 8-bit registers to control baud rate, select SCI options, report SCI status, and for transmit/receive data.

Refer to the direct-page register summary in the Memory chapter of this data sheet for the absolute address assignments for all SCI registers. This section refers to registers and control bits only by their names. A Freescale-provided equate or header file is used to translate these names into the appropriate absolute addresses.

14.2.1 SCI Baud Rate Registers (SCIxBDH, SCIxBDL)

This pair of registers controls the prescale divisor for SCI baud rate generation. To update the 13-bit baud rate setting [SBR12:SBR0], first write to SCIxBDH to buffer the high half of the new value and then write to SCIxBDL. The working value in SCIxBDH does not change until SCIxBDL is written.

SCIxBDL is reset to a non-zero value, so after reset the baud rate generator remains disabled until the first time the receiver or transmitter is enabled (RE or TE bits in SCIxC2 are written to 1).



Figure 14-4. SCI Baud Rate Register (SCIxBDH)

Table 14-2. SCIxBDH Field Descript	tions
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Field	Description			
7 LBKDIE	 LIN Break Detect Interrupt Enable (for LBKDIF) 0 Hardware interrupts from LBKDIF disabled (use polling). 1 Hardware interrupt requested when LBKDIF flag is 1. 			
6 RXEDGIE	RxD Input Active Edge Interrupt Enable (for RXEDGIF)0Hardware interrupts from RXEDGIF disabled (use polling).1Hardware interrupt requested when RXEDGIF flag is 1.			
4:0 SBR[12:8]	Baud Rate Modulo Divisor — The 13 bits in SBR[12:0] are referred to collectively as BR, and they set the modulo divide rate for the SCI baud rate generator. When BR = 0, the SCI baud rate generator is disabled to reduce supply current. When BR = 1 to 8191, the SCI baud rate = BUSCLK/($16 \times BR$). See also BR bits in Table 14-3.			



16.4.1.3 Counting Modes

The main timer counter has two counting modes. When center-aligned PWM is selected (CPWMS=1), the counter operates in up/down counting mode. Otherwise, the counter operates as a simple up counter. As an up counter, the timer counter counts from 0x0000 through its terminal count and then continues with 0x0000. The terminal count is 0xFFFF or a modulus value in TPMxMODH:TPMxMODL.

When center-aligned PWM operation is specified, the counter counts up from 0x0000 through its terminal count and then down to 0x0000 where it changes back to up counting. Both 0x0000 and the terminal count value are normal length counts (one timer clock period long). In this mode, the timer overflow flag (TOF) becomes set at the end of the terminal-count period (as the count changes to the next lower count value).

16.4.1.4 Manual Counter Reset

The main timer counter can be manually reset at any time by writing any value to either half of TPMxCNTH or TPMxCNTL. Resetting the counter in this manner also resets the coherency mechanism in case only half of the counter was read before resetting the count.

16.4.2 Channel Mode Selection

Provided CPWMS=0, the MSnB and MSnA control bits in the channel n status and control registers determine the basic mode of operation for the corresponding channel. Choices include input capture, output compare, and edge-aligned PWM.

16.4.2.1 Input Capture Mode

With the input-capture function, the TPM can capture the time at which an external event occurs. When an active edge occurs on the pin of an input-capture channel, the TPM latches the contents of the TPM counter into the channel-value registers (TPMxCnVH:TPMxCnVL). Rising edges, falling edges, or any edge may be chosen as the active edge that triggers an input capture.

In input capture mode, the TPMxCnVH and TPMxCnVL registers are read only.

When either half of the 16-bit capture register is read, the other half is latched into a buffer to support coherent 16-bit accesses in big-endian or little-endian order. The coherency sequence can be manually reset by writing to the channel status/control register (TPMxCnSC).

An input capture event sets a flag bit (CHnF) which may optionally generate a CPU interrupt request.

While in BDM, the input capture function works as configured by the user. When an external event occurs, the TPM latches the contents of the TPM counter (which is frozen because of the BDM mode) into the channel value registers and sets the flag bit.

16.4.2.2 Output Compare Mode

With the output-compare function, the TPM can generate timed pulses with programmable position, polarity, duration, and frequency. When the counter reaches the value in the channel-value registers of an output-compare channel, the TPM can set, clear, or toggle the channel pin.



Chapter 17 Development Support



¹ BDFR is writable only through serial background mode debug commands, not from user programs.

Figure 17-6. System Background Debug Force Reset Register (SBDFR)

Table 17-3. SBDFR Register Field Description

Field	Description
0 BDFR	Background Debug Force Reset — A serial active background mode command such as WRITE_BYTE allows an external debug host to force a target system reset. Writing 1 to this bit forces an MCU reset. This bit cannot be written from a user program.

17.4.3 DBG Registers and Control Bits

The debug module includes nine bytes of register space for three 16-bit registers and three 8-bit control and status registers. These registers are located in the high register space of the normal memory map so they are accessible to normal application programs. These registers are rarely if ever accessed by normal user application programs with the possible exception of a ROM patching mechanism that uses the breakpoint logic.

17.4.3.1 Debug Comparator A High Register (DBGCAH)

This register contains compare value bits for the high-order eight bits of comparator A. This register is forced to 0x00 at reset and can be read at any time or written at any time unless ARM = 1.

17.4.3.2 Debug Comparator A Low Register (DBGCAL)

This register contains compare value bits for the low-order eight bits of comparator A. This register is forced to 0x00 at reset and can be read at any time or written at any time unless ARM = 1.

17.4.3.3 Debug Comparator B High Register (DBGCBH)

This register contains compare value bits for the high-order eight bits of comparator B. This register is forced to 0x00 at reset and can be read at any time or written at any time unless ARM = 1.

17.4.3.4 Debug Comparator B Low Register (DBGCBL)

This register contains compare value bits for the low-order eight bits of comparator B. This register is forced to 0x00 at reset and can be read at any time or written at any time unless ARM = 1.



Chapter 17 Development Support

17.4.3.9 Debug Status Register (DBGS)

This is a read-only status register.



Figure 17-9. Debug Status Register (DBGS)

Table 17-6.	DBGS	Register	Field	Descriptions
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Field	Description					
7 AF	 Trigger Match A Flag — AF is cleared at the start of a debug run and indicates whether a trigger match A condition was met since arming. 0 Comparator A has not matched 1 Comparator A match 					
6 BF	 Trigger Match B Flag — BF is cleared at the start of a debug run and indicates whether a trigger match B condition was met since arming. 0 Comparator B has not matched 1 Comparator B match 					
5 ARMF	 Arm Flag — While DBGEN = 1, this status bit is a read-only image of ARM in DBGC. This bit is set by writing 1 to the ARM control bit in DBGC (while DBGEN = 1) and is automatically cleared at the end of a debug run. A debug run is completed when the FIFO is full (begin trace) or when a trigger event is detected (end trace). A debug run can also be ended manually by writing 0 to ARM or DBGEN in DBGC. 0 Debugger not armed 1 Debugger armed 					
3:0 CNT[3:0]	FIFO Valid Count — These bits are cleared at the start of a debug run and indicate the number of words of valid data in the FIFO at the end of a debug run. The value in CNT does not decrement as data is read out of the FIFO. The external debug host is responsible for keeping track of the count as information is read out of the FIFO. 0000 Number of valid words in FIFO = No valid data 0001 Number of valid words in FIFO = 1 0010 Number of valid words in FIFO = 2 0011 Number of valid words in FIFO = 3 0100 Number of valid words in FIFO = 4 0101 Number of valid words in FIFO = 5 0110 Number of valid words in FIFO = 5 0110 Number of valid words in FIFO = 7 1000 Number of valid words in FIFO = 7 1000 Number of valid words in FIFO = 8					



CPWMS	MSnB:MSnA	ELSnB:ELSnA	Mode	Configuration	
Х	XX	00	Pin not used for TPM channel; use as an external clock for the TPM or revert to general-purpose I/O		
0	00	01	Input capture	Capture on rising edge only	
		10		Capture on falling edge only	
		11		Capture on rising or falling edge	
	01	00	Output	Software compare only	
		01	compare	Toggle output on compare	
		10		Clear output on compare	
		11		Set output on compare	
	1X	10	Edge-aligned	High-true pulses (clear output on compare)	
		X1	PWM	Low-true pulses (set output on compare)	
1	XX	10	Center-aligned	High-true pulses (clear output on compare-up)	
		X1	PWM	Low-true pulses (set output on compare-up)	

Table	B-5.	Mode.	Edge.	and Lev	el Selection
Tubic	D U.	mouc,	Lugo,		00000000

If the associated port pin is not stable for at least two bus clock cycles before changing to input capture mode, it is possible to get an unexpected indication of an edge trigger. Typically, a program would clear status flags after changing channel configuration bits and before enabling channel interrupts or using the status flags to avoid any unexpected behavior.

B.2.5 Timer Channel Value Registers (TPMxCnVH:TPMxCnVL)

These read/write registers contain the captured TPM counter value of the input capture function or the output compare value for the output compare or PWM functions. The channel value registers are cleared by reset.



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